



## SSC65TR10GTF

Trench FSII Fast IGBT

### ➤ Features

$V_{CES}$	$V_{GES}$	$I_c$
650V	$\pm 20V$	20A@25°C
		10A@100°C

### ➤ Description

- High ruggedness performance
- 10 $\mu$ s short circuit capability
- High efficiency for motor control
- Excellent current sharing in parallel operation
- RoHS compliant

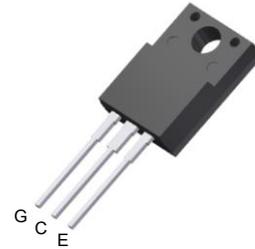
### ➤ Applications

- Welding Machines
- PFC Circuits
- UPS
- Power Inverters

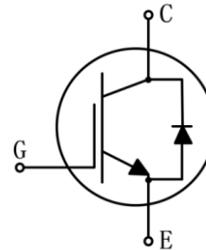
### ➤ Ordering Information

Device	Package	Shipping
SSC65TR10GTF	TO-220F-3L	50/Tube

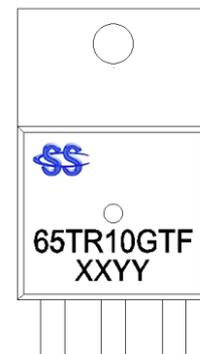
### ➤ Pin Configuration



**TO-220F-3L (Top View)**



**Pin Configuration**



**Marking**

(XXYY: Internal Traceability Code)



➤ **Absolute Maximum Ratings ( $T_{vj}=25^{\circ}\text{C}$  unless otherwise noted)**

Symbol	Parameter	Ratings	Unit	
$V_{CES}$	Collector-Emitter Voltage	650	V	
$V_{GES}$	Gate-Emitter Voltage	$\pm 20$	V	
$I_C$	Collector Current	$T_C=25^{\circ}\text{C}$	20	A
		$T_C=100^{\circ}\text{C}$	10	
$I_{Cpuls}$	Pulsed Collector Current, $t_p$ limited by $T_{vjmax}$	40	A	
$P_D$	Power Dissipation <sup>a</sup>	$T_C=25^{\circ}\text{C}$	33	W
		$T_C=100^{\circ}\text{C}$	16	
$T_J$	Operating Junction and Storage Temperature Range	-40~175	$^{\circ}\text{C}$	
$T_{STG}$	Operating Junction and Storage Temperature Range	-55~150	$^{\circ}\text{C}$	
$t_{sc}$	Short circuit withstand time	10	us	

➤ **Thermal Resistance Ratings**

Symbol	Parameter	Typ	Max	Unit
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance		65	$^{\circ}\text{C}/\text{W}$
$R_{\theta JC}$	Thermal Resistance, Junction to Case for IGBT		4.5	
$R_{\theta JC}$	Thermal Resistance, Junction to Case for Diode		5.8	

Note:

a. The maximum current rating is package limited



➤ **Electrical Characteristics of IGBT ( $T_{vj}=25^{\circ}\text{C}$  unless otherwise noted)**

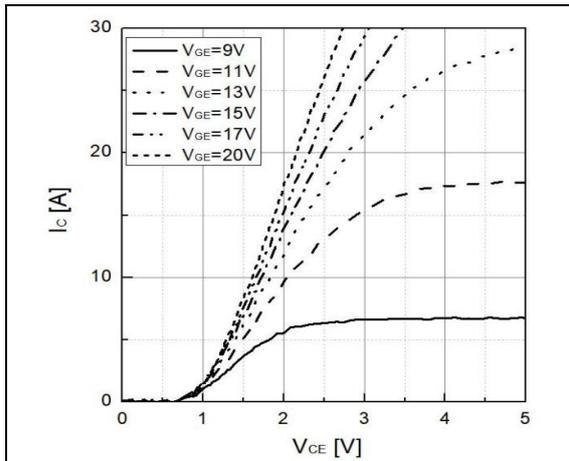
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CES}$	Collector-Emitter Breakdown Voltage	$V_{GE} = 0\text{V}, I_C = 0.25\text{mA}$	650			V
$I_{CES}$	Collector-Emitter Leakage Current	$V_{GE}=0\text{V}, V_{CE}=650\text{V}, T_{vj}=25^{\circ}\text{C}$			50	$\mu\text{A}$
$I_{GES(F)}$	Gate to Emitter Forward Leakage	$V_{GE} = +20\text{V}, V_{CE} = 0\text{V}$			100	nA
$I_{GES(R)}$	Gate to Emitter Reverse Leakage	$V_{GE} = -20\text{V}, V_{CE} = 0\text{V}$			-100	nA
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C=10\text{A}, V_{GE}=15\text{V}, T_{vj}=25^{\circ}\text{C}$		1.78		V
		$I_C=10\text{A}, V_{GE}=15\text{V}, T_{vj}=150^{\circ}\text{C}$		2.05		V
$V_{GE(th)}$	Gate Threshold Voltage	$I_C = 250\mu\text{A}, V_{CE} = V_{GE}$	5.2	5.7	6.2	V
$C_{ies}$	Input Capacitance	$V_{CE} = 30\text{V}, V_{GE} = 0\text{V},$ $f = 1\text{MHz}$		680		pF
$C_{oes}$	Output Capacitance			40		
$C_{res}$	Reverse Transfer Capacitance			12		
$T_{D(ON)}$	Turn-on delay time	$T_{vj}=25^{\circ}\text{C}, V_{CC}=400\text{V}, I_C=10\text{A},$ $V_{GE}=0/15\text{V}, R_g=10\Omega,$ Inductive Load		13		ns
$T_r$	Rise time			12		
$T_{D(OFF)}$	Turn-off delay time			74		
$T_f$	Fall time			78		
$E_{on}$	Turn-On Switching Loss	Inductive Load		0.2		mJ
$E_{off}$	Turn-Off Switching Loss			0.18		
$E_{ts}$	Total Switching Loss			0.38		
$T_{D(ON)}$	Turn-on delay time	$T_{vj}=150^{\circ}\text{C}, V_{CC}=400\text{V},$ $I_C=10\text{A},$ $V_{GE}=0/15\text{V}, R_g=10\Omega,$ Inductive Load		12		ns
$T_r$	Rise time			15		
$T_{D(OFF)}$	Turn-off delay time			87		
$T_f$	Fall time			115		mJ
$E_{on}$	Turn-On Switching Loss			0.23		
$E_{off}$	Turn-Off Switching Loss			0.28		
$E_{ts}$	Total Switching Loss		0.51			
$Q_G$	Total Gate Charge	$V_{CC} = 520\text{V}, I_C = 10\text{A},$ $V_{GE} = 0/15\text{V}$		31		nC



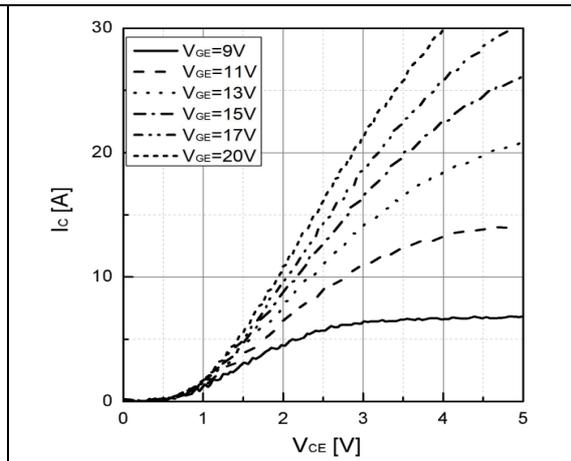
➤ **Electrical Characteristics of Diode ( $T_{vj}=25^{\circ}\text{C}$  unless otherwise noted)**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
VF	Diode forward voltage	IF=10A, $T_{vj}=25^{\circ}\text{C}$		1.45		V
		IF=10A, $T_{vj}=150^{\circ}\text{C}$		1.3		V
Trr	Diode reverse recovery time	VR=400V IF=10A diF/dt=750A/ $\mu\text{s}$ $T_{vj}=25^{\circ}\text{C}$		60		ns
Irrm	Diode peak reverse recovery current			12		A
Qrr	Diode reverse recovery charge			413		nC
Trr	Diode reverse recovery time	VR=400V IF=10A diF/dt=750A/ $\mu\text{s}$ $T_{vj}=150^{\circ}\text{C}$		120		ns
Irrm	Diode peak reverse recovery current			15		A
Qrr	Diode reverse recovery charge			734		nC

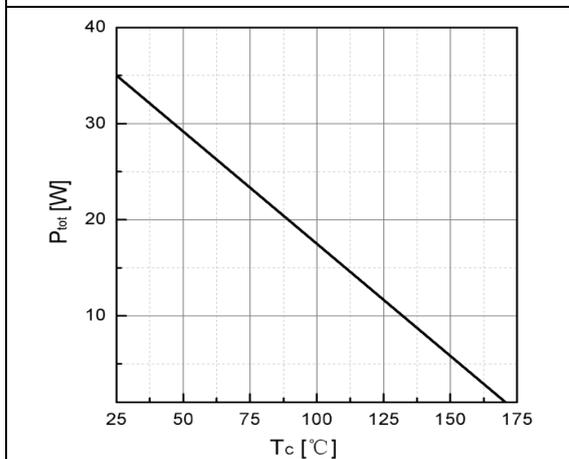
➤ **Typical Performance Characteristics ( $T_{vj}=25^{\circ}\text{C}$  unless otherwise noted)**



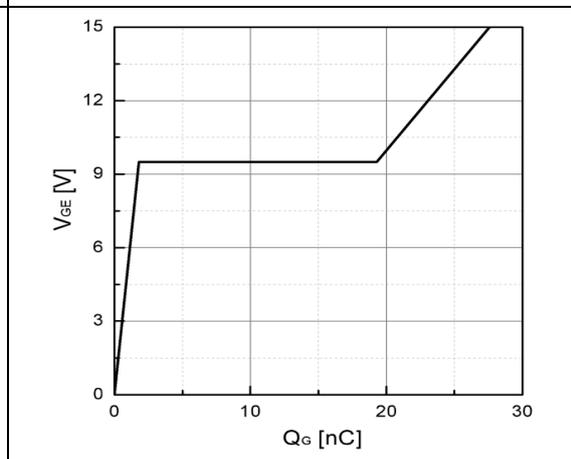
**Fig 1. Typical output characteristic ( $T_{vj}=25^{\circ}\text{C}$ )**



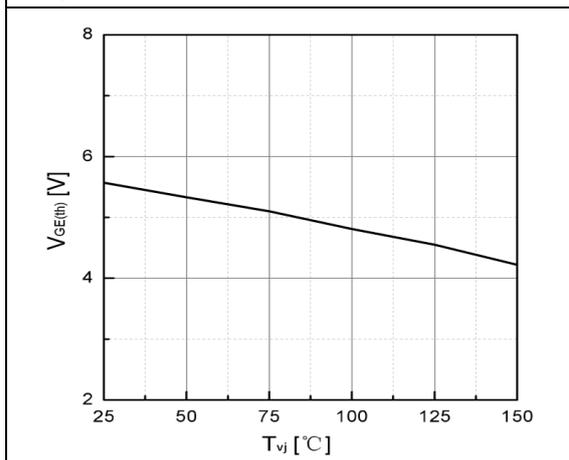
**Fig 2. Typical output characteristic ( $T_{vj}=150^{\circ}\text{C}$ )**



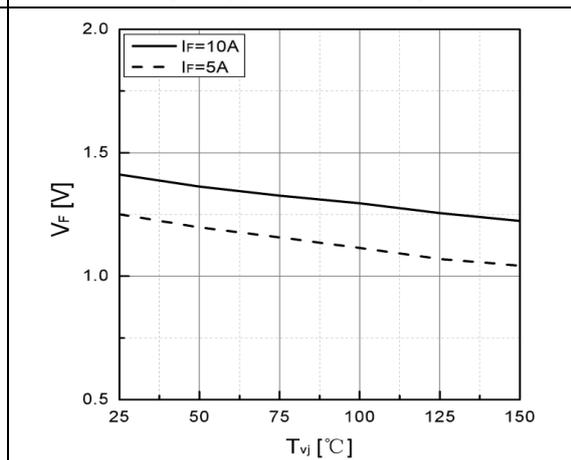
**Fig 3. Power dissipation as a function of TC**



**Fig 4. Typical Gate charge**

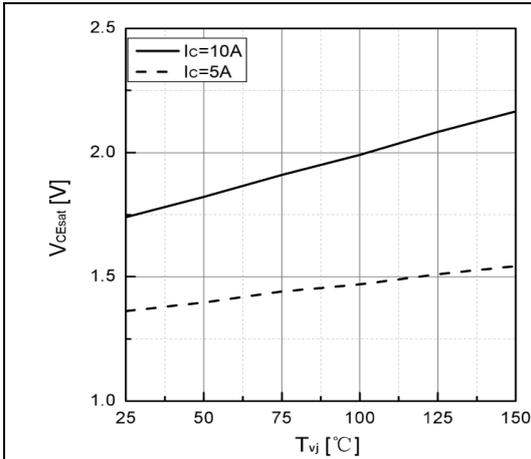


**Fig 5. Typical  $V_{GE(th)}$  as a function of  $T_{vj}$   
( $I_C=1\text{mA}$ )**

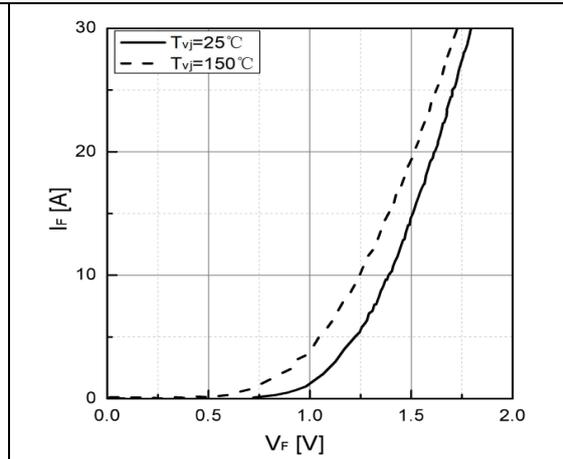


**Fig 6. Typical  $V_F$  as a function of  $T_{vj}$**

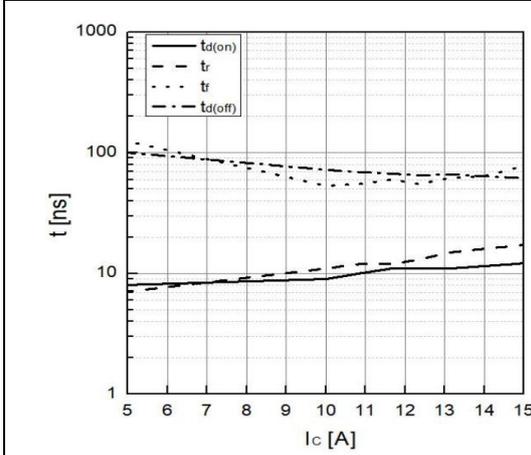
➤ **Typical Performance Characteristics ( $T_{vj}=25^{\circ}\text{C}$  unless otherwise noted)**



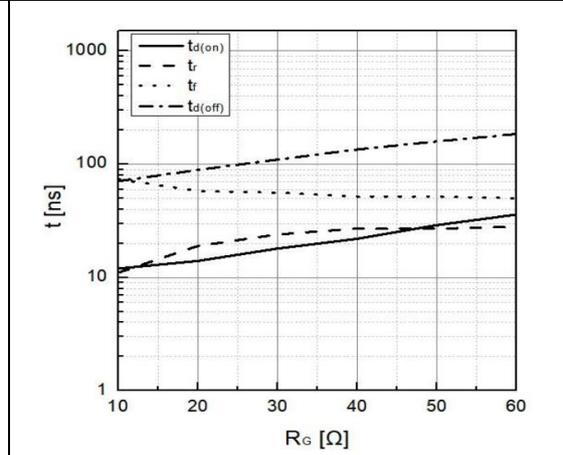
**Fig 7. Typical VCEsat as a function of  $T_{vj}$**



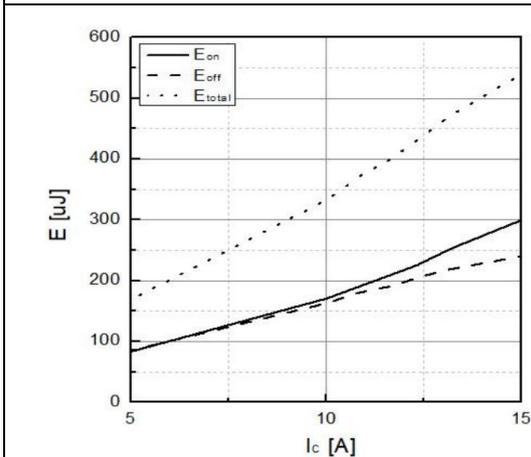
**Fig 8. Typical  $I_F$  as a function of  $V_F$**



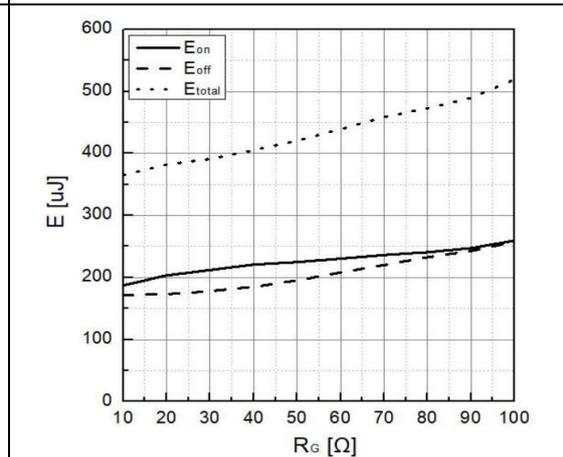
**Fig 9. Typical switching time as a function of  $I_C$**



**Fig 10. Typical switching times as a function of  $R_G$**



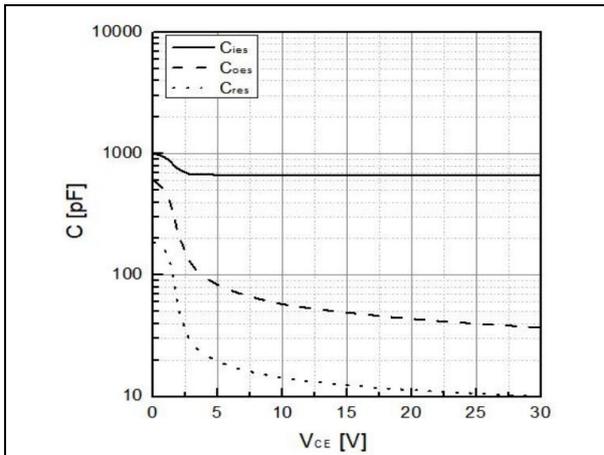
**Fig 11. Typical switching energy losses as a function of  $I_C$**



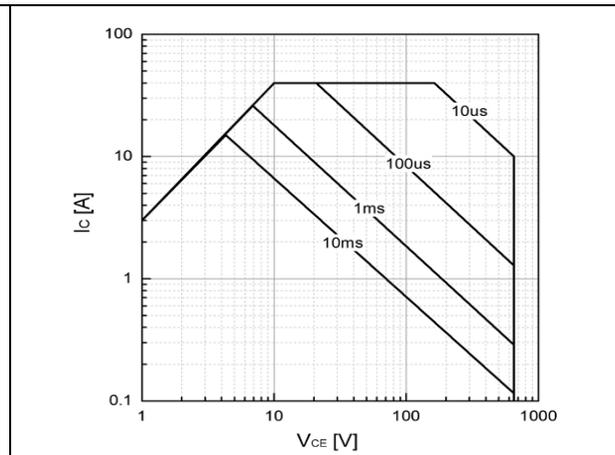
**Fig 12. Typical switching times as a function of  $R_G$**



➤ **Typical Performance Characteristics ( $T_{vj}=25^{\circ}\text{C}$  unless otherwise noted)**



**Fig 13. Typical capacitance as a function of VCE**  
(f=1Mhz, VGE=0V)

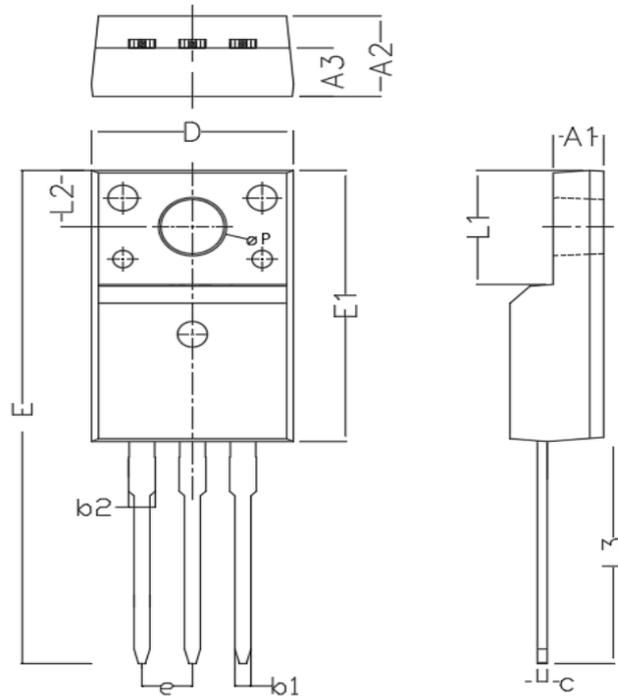


**Fig 14. Safe operating area**



## ➤ Package Information

TO220F



Symbol	MILL IMETER		
	Min	Nom	Max
A1	2.34	2.54	2.74
A2	4.5	4.7	4.9
A3	2.56	2.76	2.96
b1	0.7	0.8	0.9
b2	1.23	1.3	1.47
c	0.45	0.5	0.6
D	9.96	10.16	10.36
E	28.35	28.85	29.35
E1	15.67	15.87	16.07
e	2.54REF		
L1	6.48	6.68	6.88
L2	3.2	3.3	3.4
L3	12.68	12.98	13.28
øP	3.03	3.4	3.5



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